

Notice of References CitedApplication/Control No.
10/688,026Applicant(s)/Patent Under
Reexamination
ARAI ET AL.Examiner
David G. CervettiArt Unit
2136

Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,158,007 A	12-2000	Moreh et al.	726/1
*	B	US-6,158,010 A	12-2000	Moriconi et al.	726/1
*	C	US-6,209,101 B1	03-2001	Mitchem et al.	726/2
*	D	US-6,530,024 B1	03-2003	Proctor, Paul E.	726/23
*	E	US-2003/0115322 A1	06-2003	Moriconi et al.	709/224
*	F	US-2003/0115484 A1	06-2003	Moriconi et al.	713/201
*	G	US-2003/0226038 A1	12-2003	Raanan et al.	713/201
*	H	US-6,735,701 B1	05-2004	Jacobson, Andrea M.	726/1
*	I	US-2004/0111643 A1	06-2004	Farmer, Daniel G.	713/201
*	J	US-6,941,472 B2	09-2005	Moriconi et al.	726/11
*	K	US-6,950,818 B2	09-2005	Dennis et al.	707/3
*	L	US-7,120,931 B1	10-2006	Cheriton, David	726/13
*	M	US-7,140,035 B1	11-2006	Karch, Robert	726/1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Venkatesan et al., Threat-Adaptive Security Policy, 1997, IEEE.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/688,026	Applicant(s)/Patent Under Reexamination ARAI ET AL.	
	Examiner David G. Cervetti	Art Unit 2136	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,915,085 A	06-1999	Koved, Lawrence	726/1
*	B	US-6,044,466 A	03-2000	Anand et al.	726/1
*	C	US-6,330,562 B1	12-2001	Boden et al.	707/10
*	D	US-6,347,376 B1	02-2002	Attwood et al.	726/1
*	E	US-6,393,473 B1	05-2002	Chu, Clare	709/223
*	F	US-6,466,932 B1	10-2002	Dennis et al.	707/3
*	G	US-2003/0023587 A1	01-2003	Dennis et al.	707/3
*	H	US-2003/0182475 A1	09-2003	Gimenez, Galo	710/8
*	I	US-6,678,835 B1	01-2004	Shah et al.	714/4
*	J	US-6,948,183 B1	09-2005	Peterka, Petr	725/25
*	K	US-6,944,183 B1	09-2005	Iyer et al.	370/466
*	L	US-2006/0010492 A9	01-2006	Heintz et al.	726/023
*	M	US-7,032,022 B1	04-2006	Shanumgam et al.	709/225

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/688,026		Applicant(s)/Patent Under Reexamination ARAI ET AL.	
	Examiner David G. Cervetti		Art Unit 2136	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,529,907 B1	03-2003	Terakura et al.	707/9
*	B	US-2003/0093514 A1	05-2003	Valdes et al.	709/224
*	C	US-6,708,187 B1	03-2004	Shanumgam et al.	707/201
*	D	US-6,715,081 B1	03-2004	Attwood et al.	707/3
*	E	US-2004/0133777 A1	07-2004	Kiriansky et al.	713/166
*	F	US-6,985,845 B1	01-2006	Pisarsky, Vladimir R.	703/21
*	G	US-7,006,530 B2	02-2006	Spinar et al.	370/468
*	H	US-7,051,107 B2	05-2006	Morikawa, Ikuya	709/229
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.